



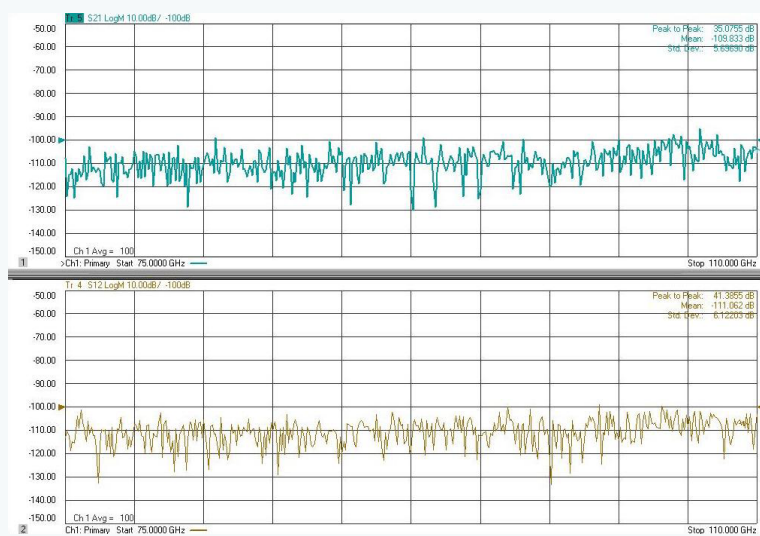
WR-10 VNA Frequency Extension Module 75-110 GHz: FEV-10-TR-0008

Farran's FEV-10 frequency extenders are a dedicated Test & Measurement solution for extending the range of your Vector Network Analyzer (VNA) to 75 – 110 GHz.

These modules connect to your VNA and leverage its performance and features to perform unilateral (TR – T) or bilateral (TR – TR) high power S-parameters measurements in 75 – 110 GHz and 88 - 96 GHz range.

Key Facts:

- Full simultaneous 2-port or 4-port large-signal network analysis
- Excellent dynamic range
- Excellent stability
- Full band high power output 75 - 110 GHz.
- Very high power output 88 - 96 GHz.



ADDITIONAL FEATURES

- Full band high output power
- Electronic power control compatibility with Agilent PNA-X
- 2-Port controller available as standard
- **TTL control interface**



APPLICATIONS

- Test and measurement frequency range extension
- Large-signal S-parameters
- Multi-port S-parameters
- Wafer probe measurement
- Antenna measurements
- Material characterisation



ACCESSORIES

- Calibration Kits
- Cables
- User Manuals
- Flight Cases
- Power Supply Unit

Over the years, Farran's FEV extenders have delivered unparalleled dynamic range and long-term stability of the measurements without the need for frequent calibrations. They can be easily configured with wide range of our VNAs and are seamlessly controlled via VNA's user interface. Great customer support and direct access to Farran's engineers, coupled with the extenders' reliability, make my job simple and stress-free.

Principal Test Engineer, European Automotive Radar Company



Product Specification

System Specification	Unit	Min	Typ	Max
Operating Frequency (ST)	GHz	75	-	110
Operating Frequency (HP)	GHz	88	-	96
Test Port Output Power (ST) 75 - 102 GHz	dBm	+13	+16.5	-
Test Port Output Power (ST) 102 - 110 GHz	dBm	+10	+13	-
Test Port Output Power (HP)	dBm	+20	+22.5	-
Dynamic Range (ST)	dB	90	110	-
Dynamic Range (HP)	dB	100	110	-
Magnitude Trace Stability (typ.)	dB	-	±0.1	-
Phase Trace Stability (typ.)	deg	-	±2	-
Test Port Input P0.1dB (nom.)	dBm	-	+30	-
Test Port Damage Level (nom.)	dBm	+31.75	-	-
RF/LO Port Damage Level (nom.)	dBm	+15	-	-
Raw Coupler Directivity (nom.)	dB	35	45	-
RF Multiplier Number (nom.)	-	-	6	-
RF/LO Power Input	dBm	5	-	10
LO Harmonic Number (nom.)	-	-	8	-
RF Test Port (nom.)	-	WR-10, IEEE 1785.2a (UG-387/UM compatible)		
IF Bandwidth (nom.)	MHz	5	-	50
RF/LO/IF Ports	-	SMA(F)		
TTL Control Port	-	D-sub 9-pin		
DC Power Requirements (typ.)	-	+6V @ 1.5A, +15 @ 500mA		
Dimensions (approx.)	mm	375 x 105 x 60		
Weight (approx.)	kg	2.75		
Operating Temperatures (nom.)	°C	0	-	30



SERVICES AVAILABLE

- Technical Support
- Installation and Setup
- Maintenance
- Application Support
- Hardware Support

For more information on any of our products or services please visit our website: www.farran.com



TECHNICAL SUPPORT

- Technical support provided directly by our knowledgeable and friendly engineers.
- Support for pre- and post-purchase: system configuration, installation and troubleshooting.



PRODUCT INSIGHTS

- For more product insights register at www.farran.com/customer
- Additional information: test data, CAD drawings and 3D models available.



WARRANTY

- Standard 3 year warranty.
- Up to 5 year warranty optional.

Specification Definitions

ST - standard mode, **HP** - high power mode. **Nominal value (nom.)** – ensured by design, not tested. **Measured value (min, max)** – expected and warranted product performance obtained from the actual measurements of product sample. **Non-traceable measured value (n. trc. meas.)** – expected product performance obtained from the actual measurements of a product sample by means of using Farran's own equipment and methods. Traceable only to Farran laboratory equipment. **Typical data (typ.)** – value that represents the product specification met over 90% of bandwidth or a mean value.

Specifications without limits – represent the warranted product performance; with values of no or a negligible deviation from the given value and as such have a secondary impact on the product performance.

